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LIST OF REFERENCES CITED BY APPLICANT
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U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<i>[Signature]</i>	AA	2001/0023421	09/20/01	Numao et al.			
	AB						
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FOREIGN PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
<i>[Signature]</i>	AH	JP 2001-184264	07/06/01	Japan			
<i>[Signature]</i>	AI	JP 2000-293439	10/20/00	Japan			
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OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)							
<i>[Signature]</i>	AR		"eXtensible Access Control Markup Language (XACML) Ver.1.0", [online], OASIS, 18 February, 2003				

EXAMINER DIANE SUZUKI PRIMARY EXAMINER	DATE CONSIDERED 20-11-06
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